AUG 3 0 2004	no personn	/ U.S. Pate	ent and Tr	PTO/SB/21 (02-04) Approved for use through 07/31/2006. OMB 0651-0031 rademark Office; U.S. DEPARTMENT OF COMMERCE ormation unless it displays a valid OMB control number.
AADEN	110 2010011	Application Number	10/689	
TRANSMITTAL		Filing Date	Octobe	er 20, 2003
FORM		First Named Inventor	Basceri	
(to be used for all correspondence after initial	filing)	Art Unit		
· ·	•	Examiner Name	Unkno	wn
Total Number of Pages in This Submission		Attorney Docket Number	MI22-2	
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Fee Transmittal Form Fee Attached Amendment/Reply After Final Affidavits/declaration(s) Extension of Time Request Express Abandonment Request Information Disclosure Statement Certified Copy of Priority Document(s) Response to Missing Parts/ Incomplete Application Response to Missing Parts under 37 CFR 1.52 or 1.53	Remar Custom	er No. 021567 E IS REQUIRED WITH THIS FIL ver should a fee bo		After Allowance communication to Technology Center (TC) Appeal Communication to Board of Appeals and Interferences Appeal Communication to TC (Appeal Notice, Brief, Reply Brief) Proprietary Information Status Letter Other Enclosure(s) (please Identify below): PTO Return Receipt Postcard Form PTO-1449; Copies only of cited articles and applications. ermined as owing, please Account: No. 23-0925.
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THE UNITED STATES PATENT AND TRADEMARK OFFICE

ি ব্রাটানা Application Serial No	10/689.958
Filing Date	October 20, 2003
Inventor	Cem Basceri
Assignee	Micron Technology, Inc.
Group Art Unit	2812
Examiner	Unknown
Attorney Docket No	Ml22-2417
Customer No	021567
Title: Methods of Forming Conductive Me	tal Silicides by Reaction of Metal with
Silicon	- -

INFORMATION DISCLOSURE STATEMENT References -- See Attached Form PTO-1449

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The attached form PTO-1449 is submitted in compliance with 37 CFR §1.56. Pursuant to 1276 OG 55, August 5, 2003, no copies of cited U.S. patents or U.S. patent application publications are included, as the date of filing of this patent application occurs after June 30, 2003. Copies of all other references are attached. No admission is made regarding whether all the listed references are prior art.

Citation of the referenced art is respectfully requested.

This Information Disclosure Statement is being filed before the mailing date of a first Office Action. There, no fee is believed to be required. However, in the event that a fee is required for filing this Information Disclosure Statement, please charge the fee specified under 37 C.F.R. § 1.17(p) to Deposit Account No. 23-0925.

Respectfully submitted,

Dated: $\delta/3$

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Mark S. Matkin Reg. No. 32,268 Form PTO-1449

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October 20, 2003

APPLICANT: Cem Basceri

GROUP 2812

*Examiner's Initials		Document Number	Date	Name	Class	Subclass		Date ropriate
	AA	4,086,074	04/78	Minot et al.				
	AB	4,622,735	11/86	Shibata				
	AC	4,683,645	08/87	Naguib et al.				
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Sheet 5 of 5 Form PTO-1449 U.S. DEPARTMENT OF COMMERCE ATTY. DOCKET NO. SERIAL NO. MI22-2417 PATENT AND TRADEMARK OFFICE 10/689,958 LIST OF ART CITED BY APPLICANT (Use several sheets if necessary) APPLICANT: Cem Basceri **FILING DATE GROUP** October 20, 2003 2812 U.S. PATENT DOCUMENTS *Examiner's Document Date Name Class Subclass Filing Date Initials Number If Appropriate AA 10/609,311 Yataes 06/03 ΑB 10/655,997 Daley 09/03 AC 10/690,029 Derderian et al. 10/03 AD 10/882,118 Sandhu et al. 04/04 ΑE 10/879,367 Blalock et al. 06/04 AF AG АН AJ FOREIGN PATENT DOCUMENTS Document Date Country Class SubclasS Translation Number Yes No AK AL OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) ΑN

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